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Contents

v Conference Committee

NOVEL SINGLE-PHOTON DEVICES

12512 03 Antenna-coupled graphene Josephson-junction THz/mm-wave detector [12512-6] DIFFUSE CORRELATION SPECTROSCOPY AND FLUORESCENCE LIFETIME IMAGING 1251204 A hardware approach to overcome pile-up in TCSPC: from principles to field verification [12512-11] **DEVELOPMENTS IN SINGLE-PHOTON AVALANCHE DIODES** 12512 05 Multiscale SPAD modeling: from Monte Carlo to SPICE simulations (Invited Paper) [12512-12] 1251206 Studies of spatial uniformity and jitter in SiC UV SPADs (Invited Paper) [12512-13] 1251207 Inverse doping profile extraction as an enabling tool for accurate SPAD modeling [12512-14] 12512 08 Advancements in linear-mode photon-counting HgCdTe e-APDs for space and defense applications (Invited Paper) [12512-15] SINGLE-PHOTON AVALANCHE DIODES AND LIDAR 12512 09 Radiation effects and underlying damage mechanisms in CMOS SPADs (Invited Paper) [12512-16] 12512 0A ICESat-2/ATLAS at 4 years: instrument performance and projected life (Invited Paper) [12512-17] 12512 OB Lateral-resolution enhancement of low-photon 3D-LiDAR by compressive sensing [12512-19] LIDAR

12512 OC Geiger-mode avalanche InGaAsInP photodiode focal plane arrays for 1.0um and 1.5um Lidar imaging (Invited Paper) [12512-20]

- 12512 0D Low-SWaP embedded 3D-LiDAR to detect non-cooperative targets [12512-22]
- 12512 OE Single photon flux imaging with sub-pixel resolution by motion compensation [12512-23]

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